

Title: SEMICONDUCTOR DEVICE TEST CIRCUIT AND SEMICONDUCTOR DEVICE

Inventor's Name: IKEDA, et al. Application No.: NEW Docket No.: 107337-00057

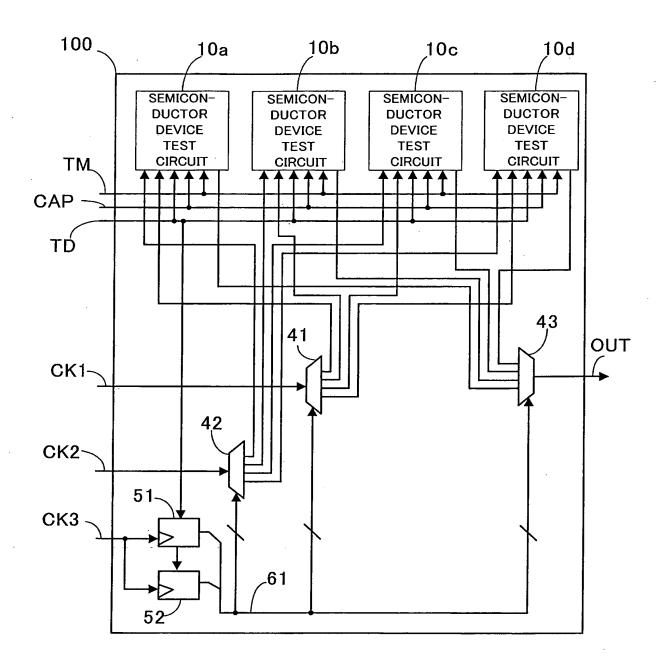


FIG. 2

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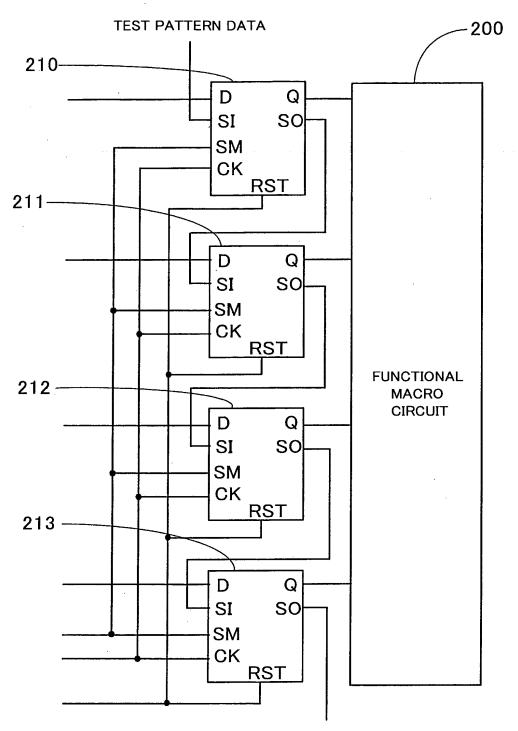


FIG. 3 PRIOR ART

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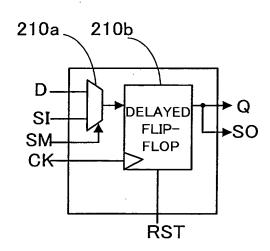


FIG. 4 PRIOR ART